

<b>Notice of References Cited</b>	Application/Control No. 10/621,077	Applicant(s)/Patent Under Reexamination OHNISHI ET AL.	
	Examiner Dinh Q. Nguyen	Art Unit 3752	Page 1 of 1

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	C	US-6,752,326	06-2004	Hirota et al.	239/102.2
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	L	US-			
	M	US-			

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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